

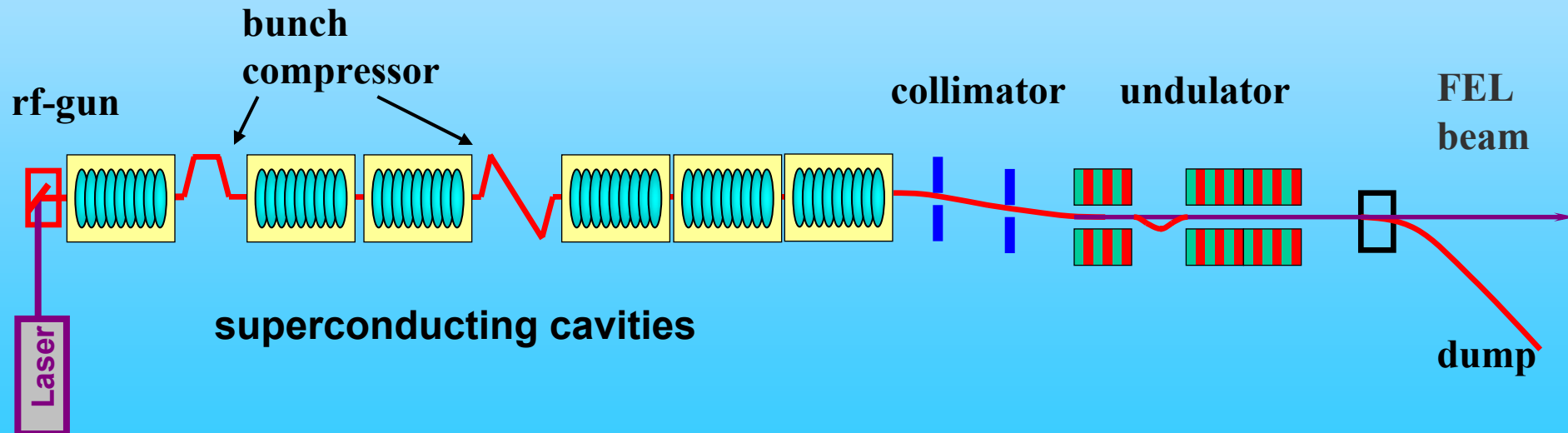
The Diagnostic System of TTF II

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TTF II at DESY:

- Superconducting 1 GeV LINAC
- Charge between 0.1 and 4 nC
- Normalized Emittance $\approx 2 \pi$ mm mrad
- Bunchlengths as short as $\approx 50 \mu\text{m}$
- Up to 7200 Bunches with 110 ns Spacing
- 10 Hz Operation
- VUV - Soft X-Ray FEL User Facility (down to ≈ 6 nm)



Challenges of the Diagnostics

- LINACs are Open Loop Systems
 - Beam Parameters change during the Pass through the Machine; They have to be measured at different Locations from Gun to Dump.
 - Diagnostics have to have Single Bunch Resolution over the whole Bunch Train.
 - Pulse to Pulse AND Bunch to Bunch Fluctuations have to be detected.
- High Duty Cycle Single Pass Machines can destroy themselves
 - Radiation Damage, Heat Load
 - Need a very sensitive fast acting Protection System.
 - Threshold and Reaction Time is determined by the most sensitive Component ($\approx 3 \mu\text{s}$).
- Challenge of Ultra short compressed Electron Bunches
 - How to measure bunch lengths in the 100 fs Regime?
- SASE Characteristics (Intensity, Pulse Length)
 - Strong Dependencies between Laser and Machine Operation
 - Operator needs FEL Parameters and their Statistics.

LINAC - Storage Rings

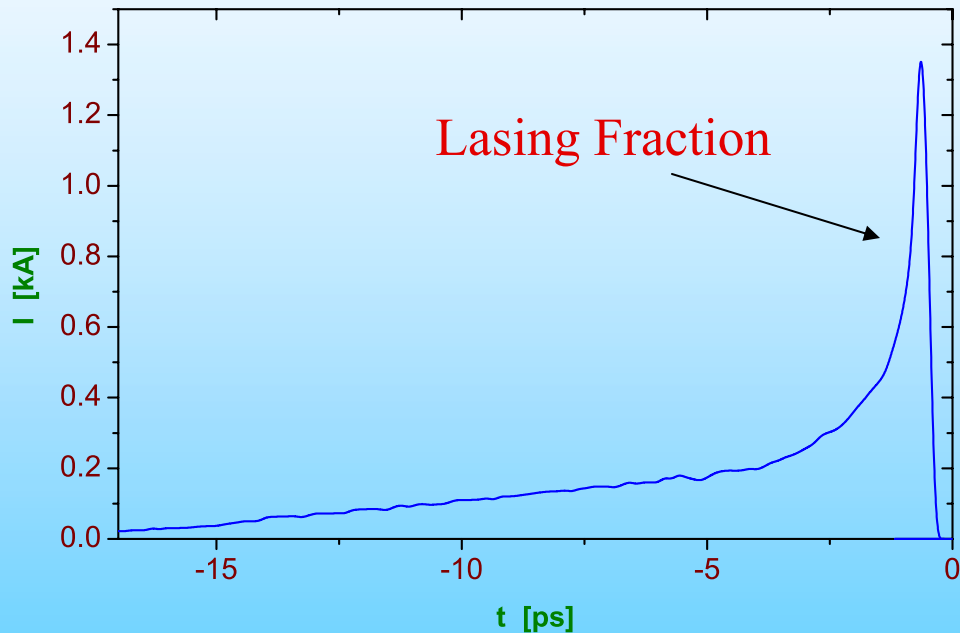
LINAC

- Pulsed System with high Fluctuations
- Triggered Electronics have to take Pulses with the rep. Rate of the Bunches.
(9 MHz for TTF II)

Storage Rings

- Closed loop Equilibrium System
- Watch beam Parameters under stable Conditions.
- Systems can be much slower and can average over long Times.
- Precise Measurements in the Frequency Domain.

... further Complication



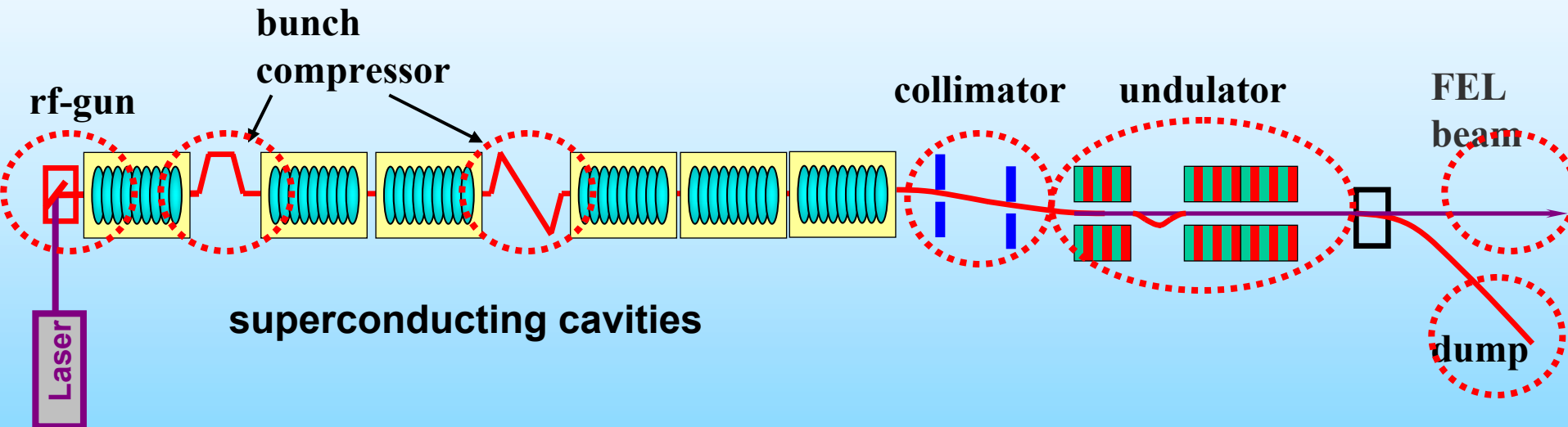
Longitudinal Charge Distribution
at TTF I

What do Monitors see:

- Mean value of charge per bunch
- Mean value of position per bunch
- Projected emittance
- ...

What is contributing to the
FEL process?

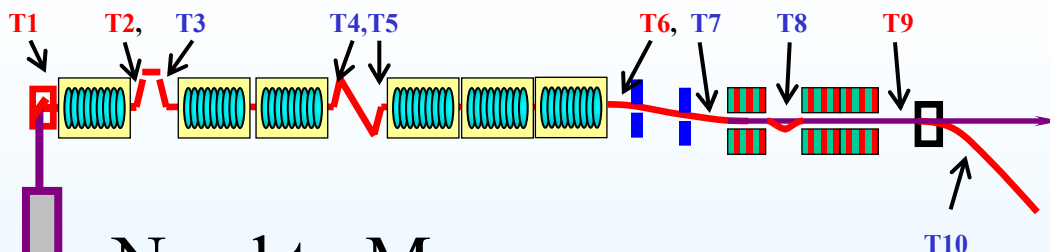
Areas of Special Interest for Diagnostics



Remark: TTF has everything, a big Machine also has, but everything concentrates in a limited Area !

„Butter and Bread Diagnostics“

- Charge

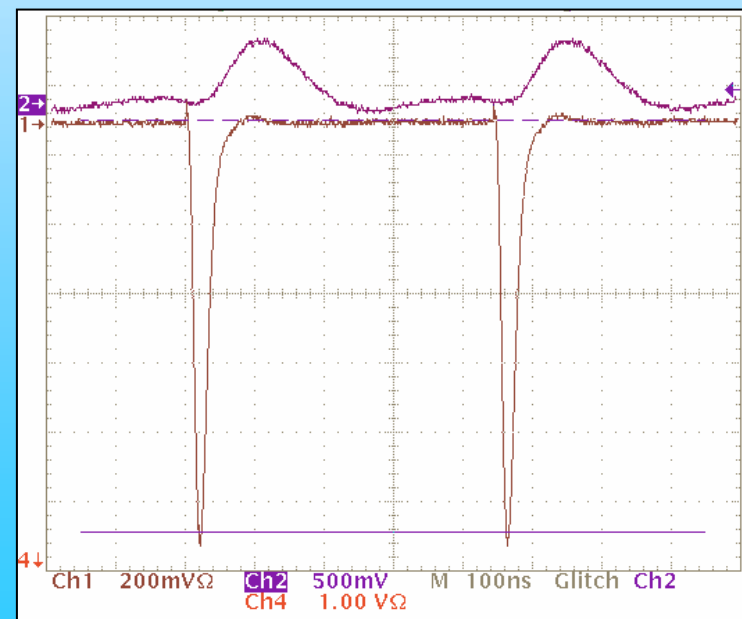
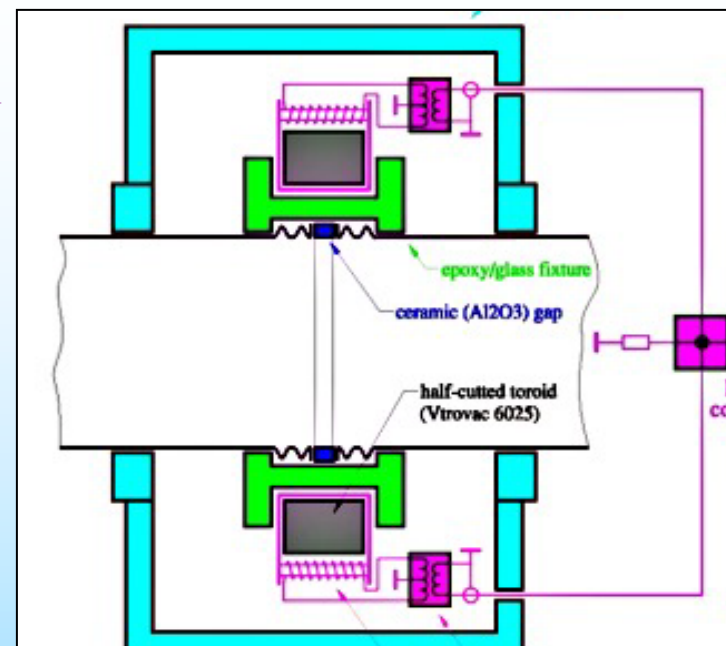


Need to Measure

- Charge
- Charge Distribution of the Bunches in the Beam Pulse
- Transmission

Fast Toroid System

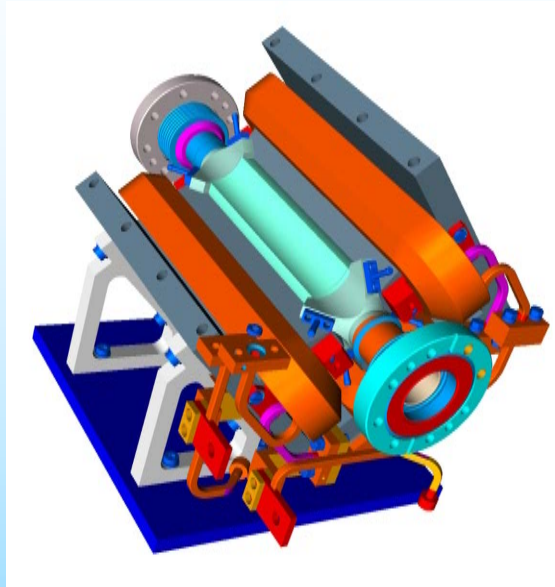
- Single Bunch Resolution
- Time Constant < 110 ns
- Bunch Rep. Rate = 9.9 MHz
- Range 0.1 to 5 nC
- Accuracy $\approx 10^{-3}$



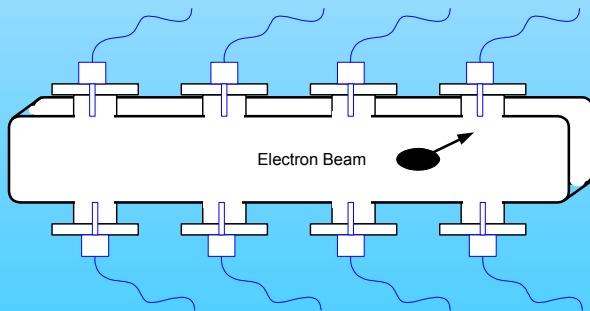
„Butter and Bread Diagnostics“

- Charge
- Beam Position

Warm Parts of TTF II: Striplines, Pickups



- Use a modular electronics system for all BPMs based on AM/PM Signal Processing
 - Single Shot, Single Bunch Readout
 - Variation of the Beam Position over the Macro Pulse
 - External Trigger
- Striplines installed inside the Quads, and aligned to the magnetic Axis (Res. $< 30 \mu\text{m}$, 34 mm Pipe)
- Button Arrays (8 Pickups per Monitor) for Bunch Compressors (large variation of Beam Position)
- Pickups in the Diagnostic Blocks between Undulator Sections and 2 inside each Undulator (Res. $\approx 10 \mu\text{m}$)



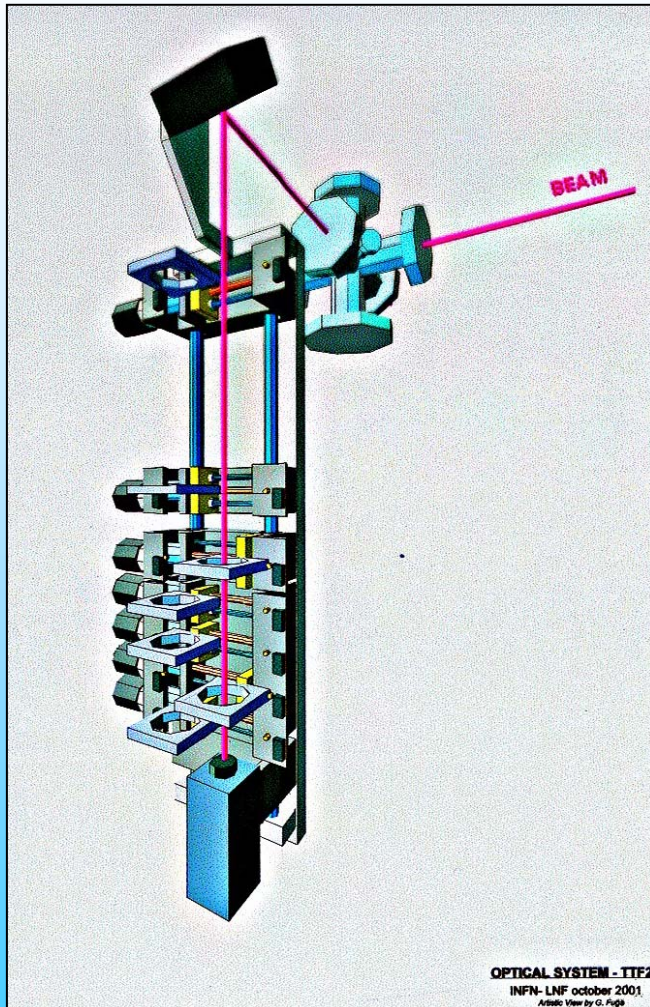
In the cold Modules:

- Cavity BPMs
- Prototype of a Cold Reentrant Cavity (by CEA)

„Butter and Bread Diagnostics“

- Charge
- Beam Position
- Transverse Electron Distribution

Screen & Wire Scanner



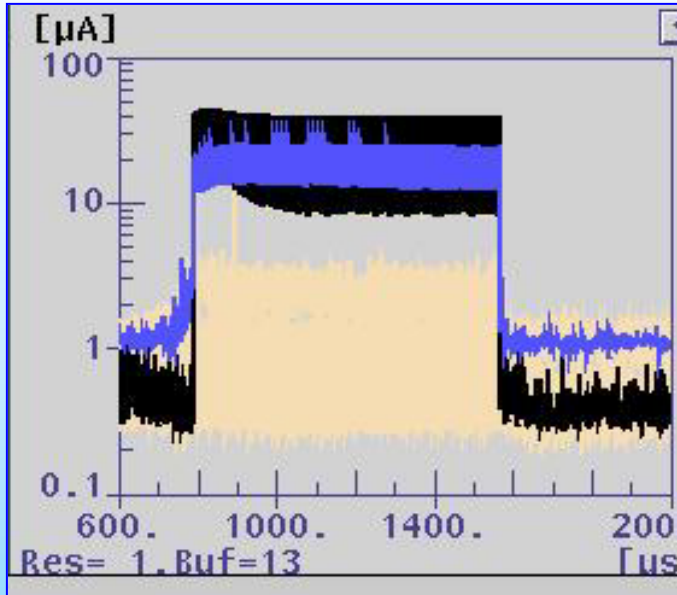
- Screens* (OTR, Diff. Radiation, Ceramics)
 - Beam Size (typical $O(100\mu\text{m})$), Measure Emittance, Energy Distribution
 - Resolution $\approx 20 \mu\text{m}$
 - Interceptive
 - Damage Threshold: 3 – 10 bunches only
- Extraction of Coherent FIR Radiation
 - Measurement of Compression
 - Measurement of Bunchlength
- Wire Scanners
 - Modified CERN Scanners with a „V Fork“ and 45° Assembly with Respect to the Beam
 - New developed Type using an unidirectional Drive Unit (used in the Undulator)

„Butter and Bread Diagnostics“

- Charge
- Beam Position
- Transverse Electron Distribution
- Dark Current

Dark Current

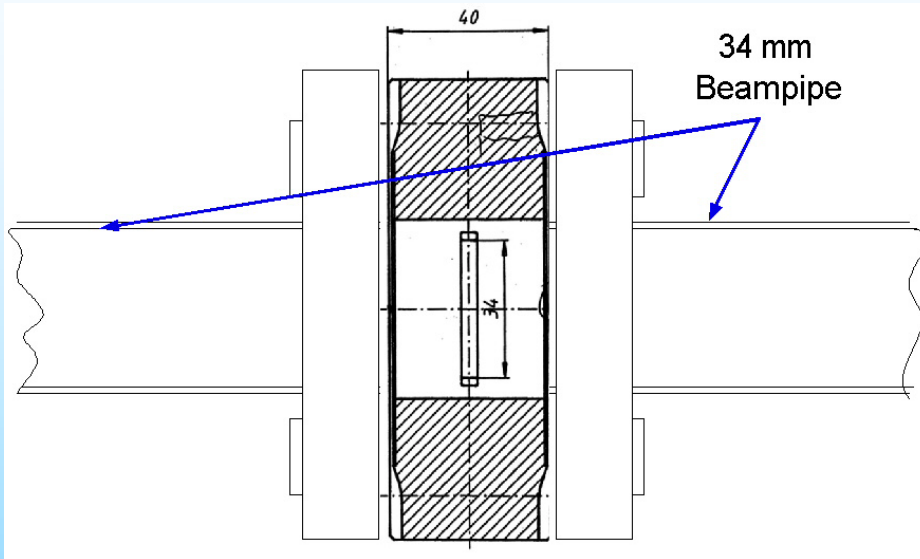
- Fills every RF-bucket
- Produces losses along the machine
- Contributes to Cryo-Load
- is emitted by the Gun
 - Increases with the age of the cathode
 - Cathode has to be changed
 - if DC gets to big compared to normal current, or
 - if DC produces to much losses
 - Measured by Sum Signal of a Reentrant Cavity BPM (O(500 nA))
- and by the Modules
 - At very high Gradients
 - Needed for Module Development
 - Sensitive Cavity Monitor (10 nA, installed outside the vacuum)



„Butter and Bread Diagnostics“

- Charge
- Beam Position
- Transverse Electron Distribution
- Dark Current
- Phase

Phase



- Isolated impedance-matched Ring Electrode installed in a „thick Flange“
 - Broadband, Position independent Signal
 - One installed after the Gun, each magnetic Chicane (BCs and Collimator)
-
- Due to magnetic Bunch Compression Energy Fluctuations turn into Phase Fluctuations
 - Beam Signal mixed with the (1.3 GHz) Master provides a Signal proportional to the Beam Phase
 - Time Of Flight Measurement: Resolution $< 0.5^\circ$ or 1 ps (tested with TTF I Stripline as a Pickup)

„Butter and Bread Diagnostics“

- Charge
- Beam Position
- Transverse Electron Distribution
- Dark Current
- Phase

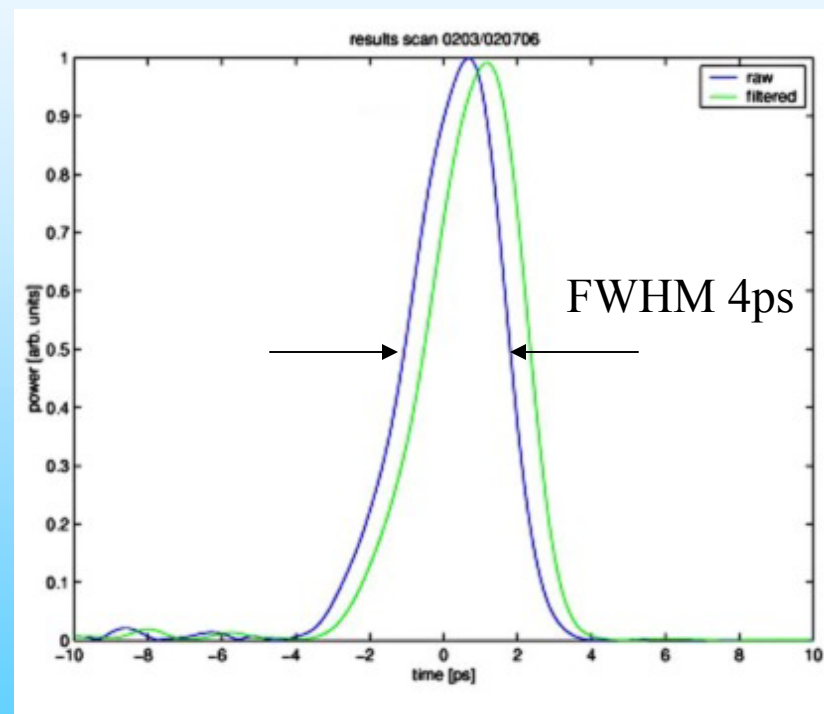
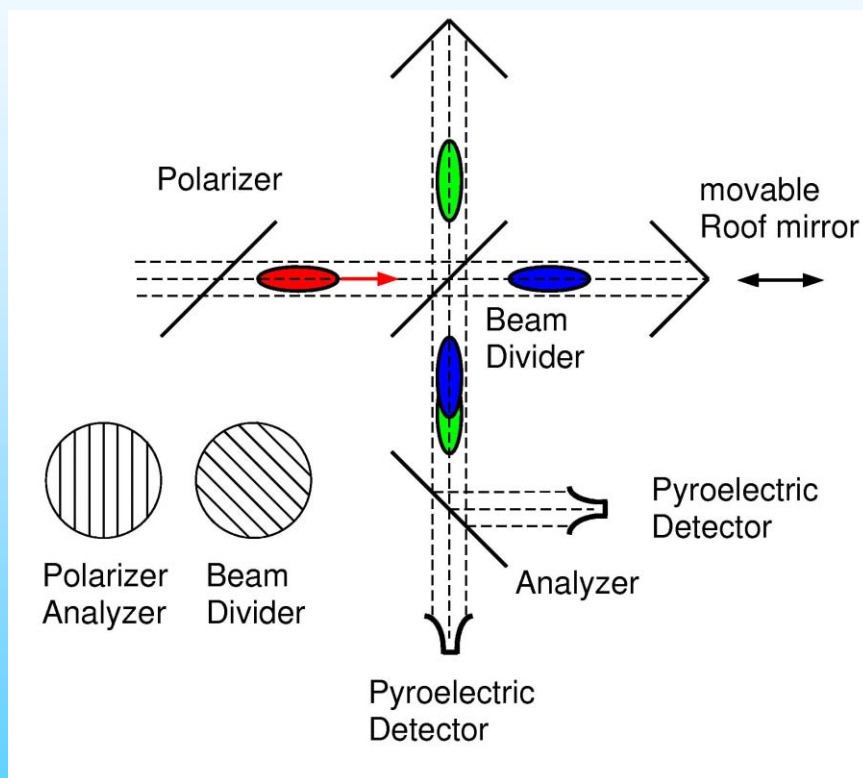
... this is not sufficient for a SASE Machine!

Bunchlength and Compression

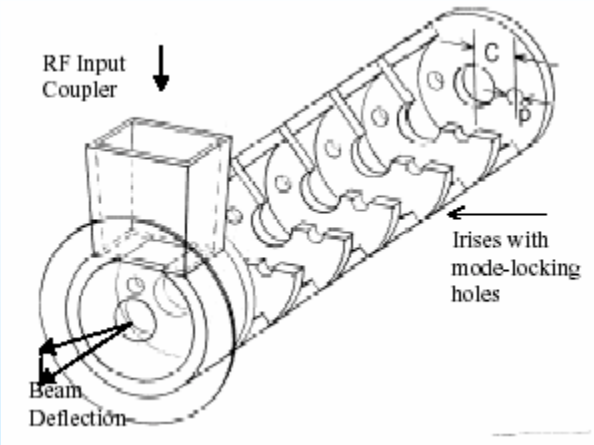
Scale: Resolve Structures of 100 fs and less

- Qualitative: Optimization of the Compression
 - Phase Tuning to maximize the coherent FIR Emission from the Beam.
 - Emission $\approx n^2$ for $\sigma_s \leq \lambda$
 - Use of simple Pyro-Detectors in the FIR
- Quantitative: Measurement of Bunch Length
 - Use coherent FIR Radiation and Autocorrelation Methods.
 - Transverse Mode Cavity (integrated Streak Camera)
 - Electro-Optical-Sampling

Interferometric Bunch Length Measurements

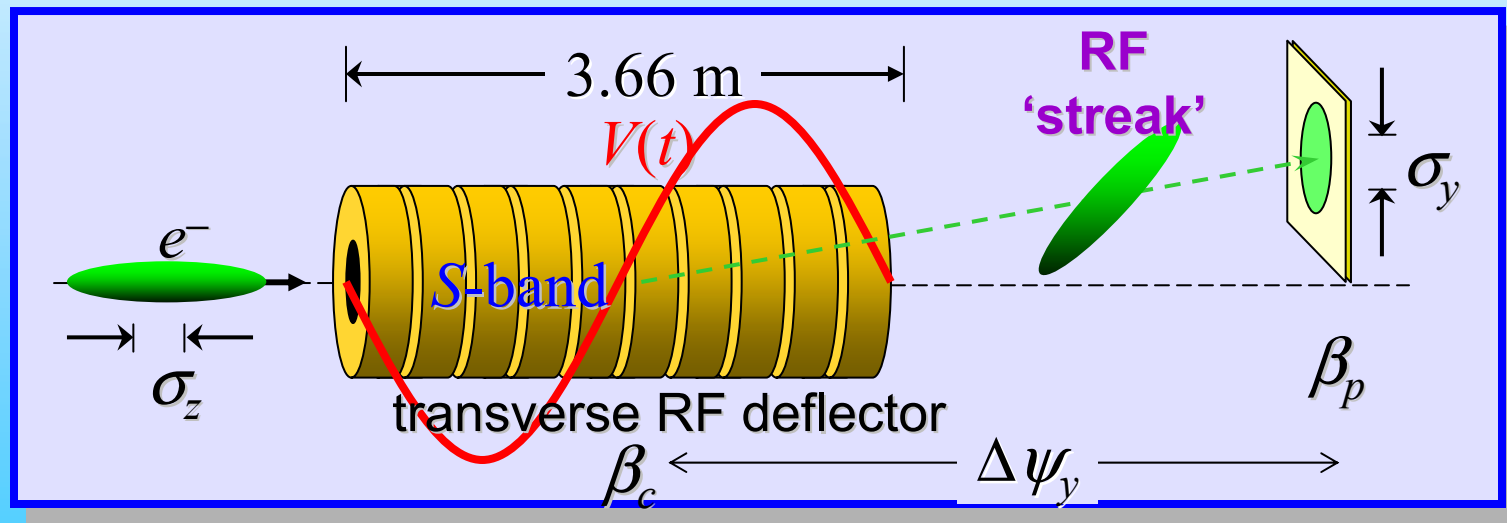


Using Coherent Transition and Diffraction Radiation

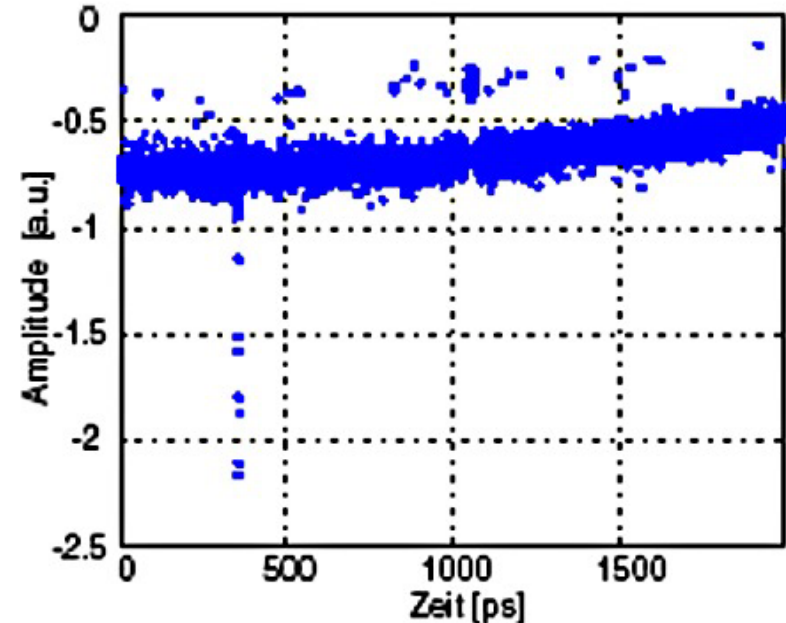
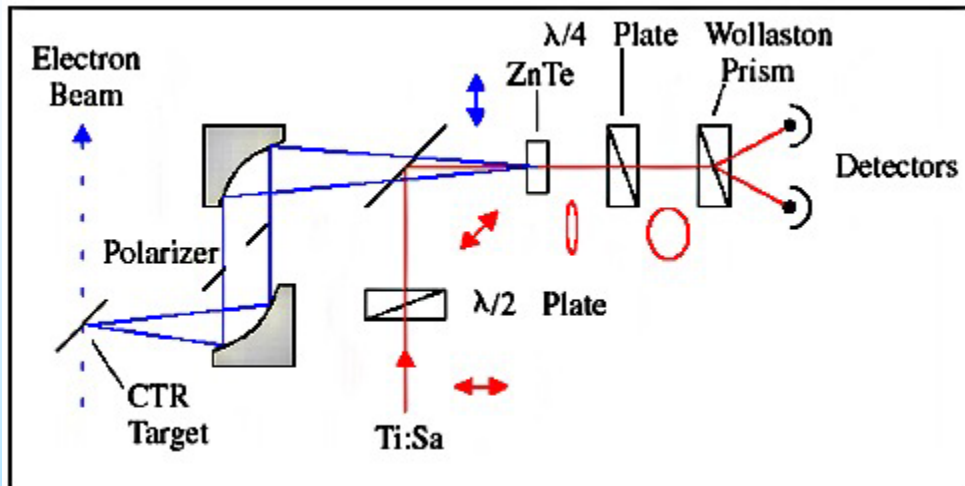


Transverse Mode Cavity: „Intra Beam-Streak Kamera“

Poster on Transverse Mode Cavities: Today THPRI097
By P. Emma, R. Akre, L. Bentson, P. Krejcik



Electro-Optical-Sampling



- Coherent Terahertz (Transition or Diffraction) Radiation is combined with an ultra short Ti:Sa Laser (15 fs) in a ZnTe Crystal.
- The Polarization of the Ti:Sa Laser is changed depending on the Amplitude of the „Beam Fields“.
- The Bunch Length can be scanned by varying the Delay of the Ti:Sa Laser
- Resolution limits: Laser Pulse Length and Timing Jitter of Laser and LINAC
- Single shot Measurement using a Chirped Laser are under Investigation

Protection Systems

- SASE LINAC:
 - „Biggest Welding Machine“
 - „Biggest X-Ray Tube“

Therefore:

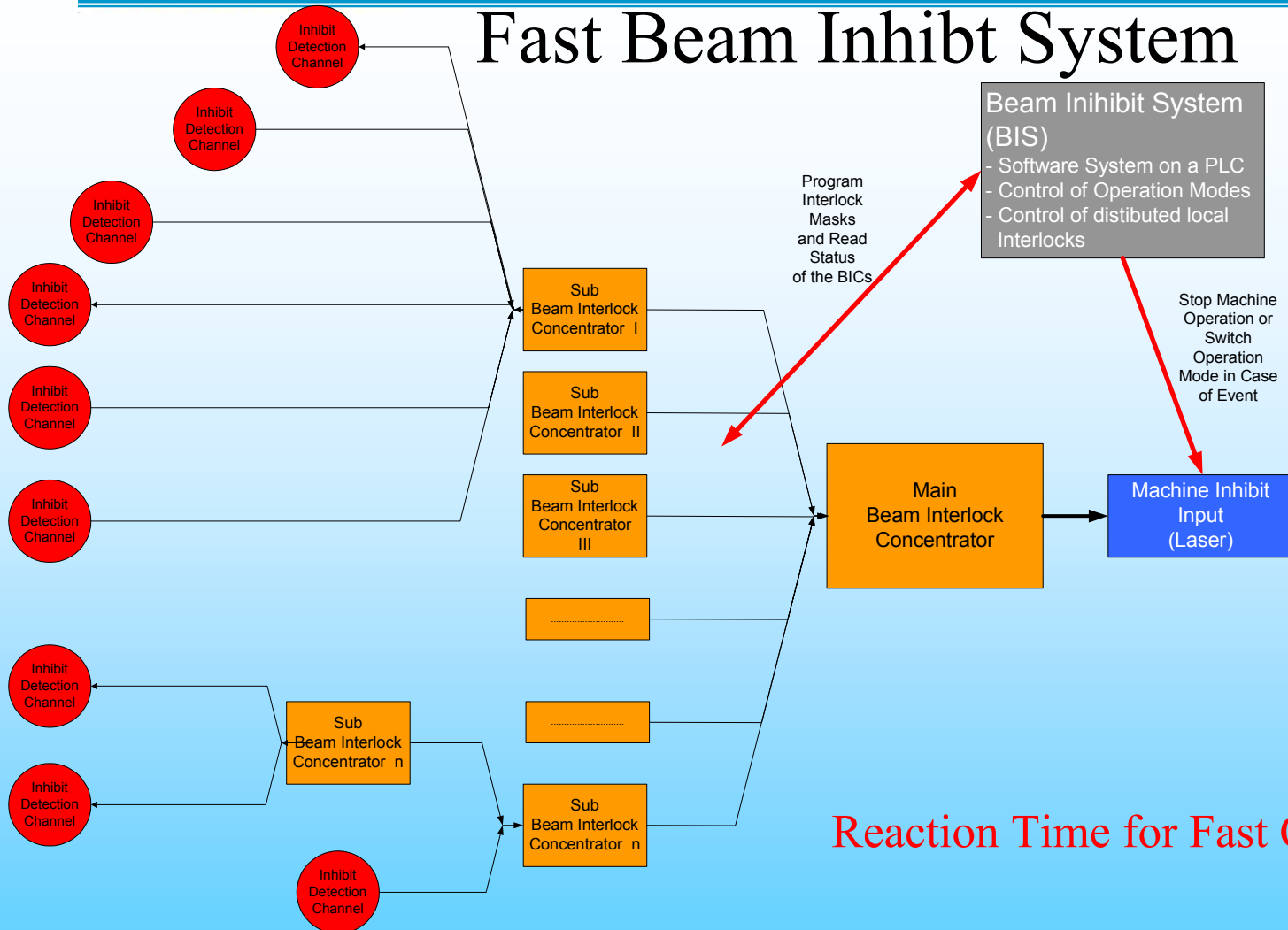
- Need of fast Interlocks to avoid Mechanical Damage.
- Need of continuous Monitoring to minimize Radiation Damage.
- Transmission and Loss based Systems
 - Thresholds given by most sensitive Component (Undulator)
 - Reaction Time by „Worst Case Events“
 - Fast and Slow Systems

Slow Loss Monitoring Systems

- TLDs
 - TLD crystals located at sensitive regions (undulator section)
 - Document the Irradiation Profile over long Times
 - Data on a weekly Basis
- Optical Fibers used as Dosimeters*
 - Small Opt Fiber Coils installed close to the Undulator Gap
 - Transmission Decrease of the Fiber due to Radiation Damage
 - Allows
 - Avoid Operation Modes with medium high losses
 - Correlation of Dose Measurement with operation Modes
 - Reaction Time \approx 1h

*In collaboration with Fraunhofer INT, Euskirchen, Germany

Fast Beam Inhibit System



Reaction Time for Fast Channels: $\approx 3 \mu\text{s}$

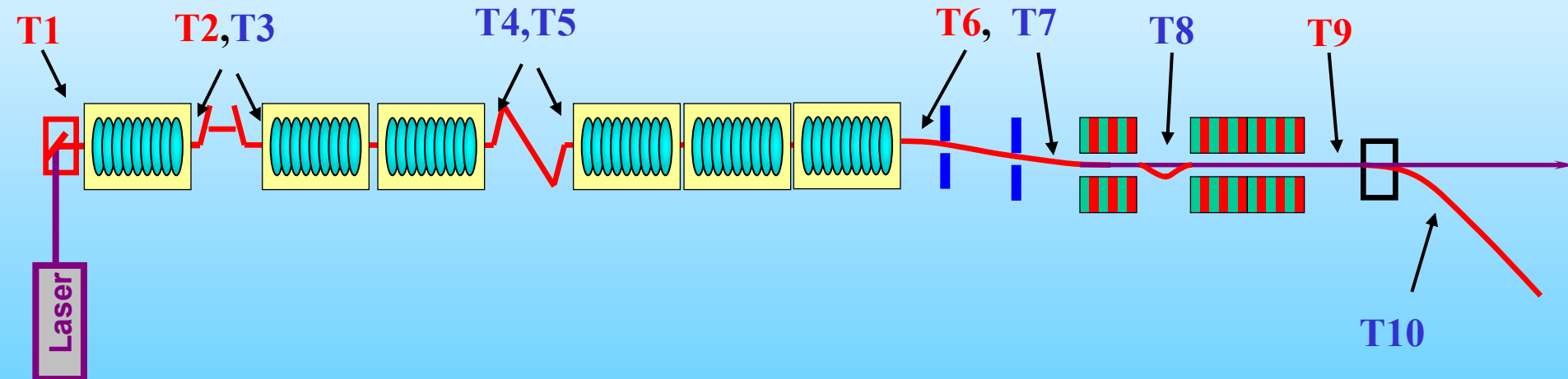
- Modular System made of fast Beam Interlock Concentrators (BIC) and Interlock Inputs with well specified interfaces.
- BIC Modules can be cascaded, Input Mask and Event Status controlled by BIS
- Interlock Inputs: Different Systems using Same Communication Protocol: Protection Systems, RF, Fast Acting Valves,

Transmission Based Protection System for TTF II

Pairs of Current Monitors + fast acting Interlock Electronics

Two Measurement:

- Fast, detecting high losses $O(10\%)$ \Rightarrow Cut this Beam Pulse
- Slow, averaging over the bunch train ($O(10^{-3})$) \Rightarrow Inhibit next Long Pulse



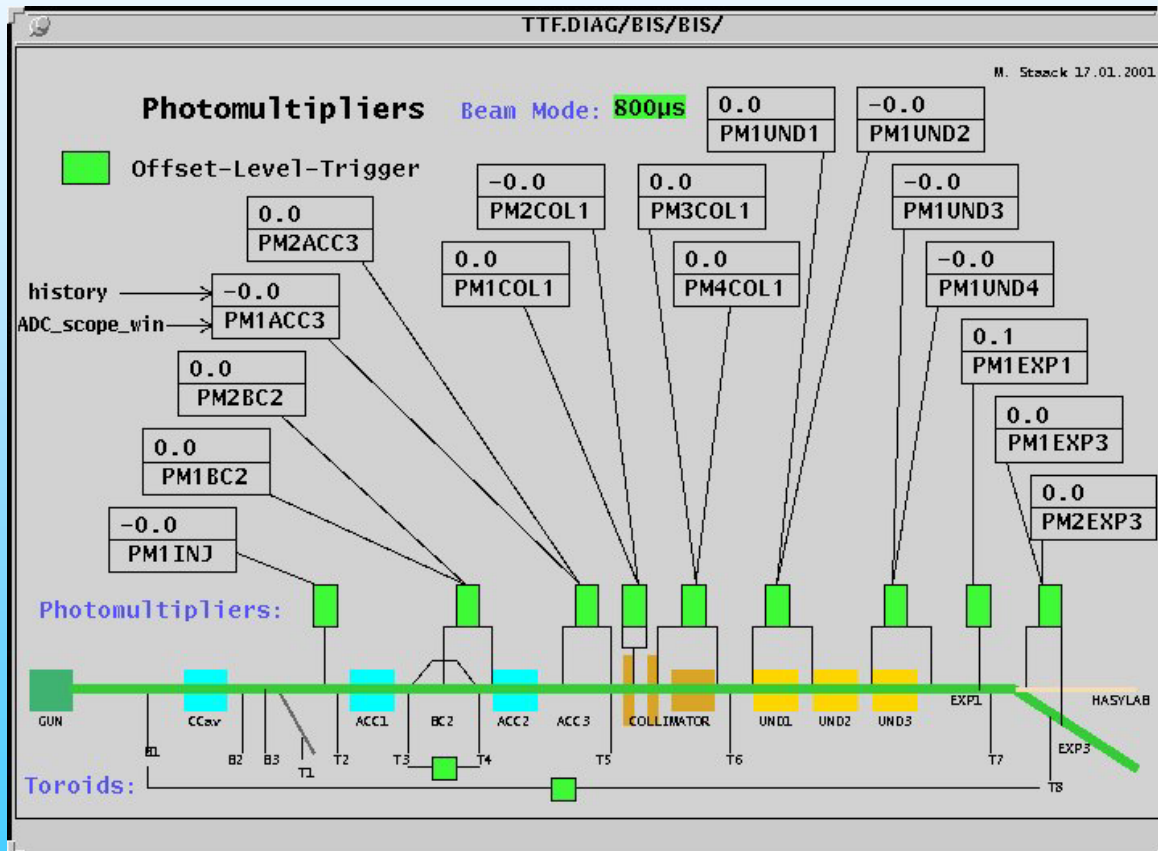
Inhibit Pairs for TTF II:

- $T_1 - T_9$: Whole Machine (FEL Mode)
- $T_1 - T_{11}$: Whole Machine (Bypass Mode)
- $T_2 - T_6$: 2nd System for both Modes

- Used for Beam Inhibit
- Charge Measurement only

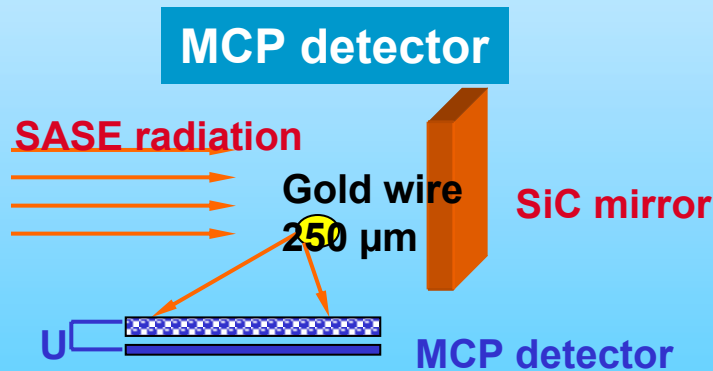
Loss Monitor Systems

- ≈ 50 Fast Loss Monitors (Photomultipliers) at critical Machine Parts
- Used as fast input Channels for the Fast Beam Inhibit system

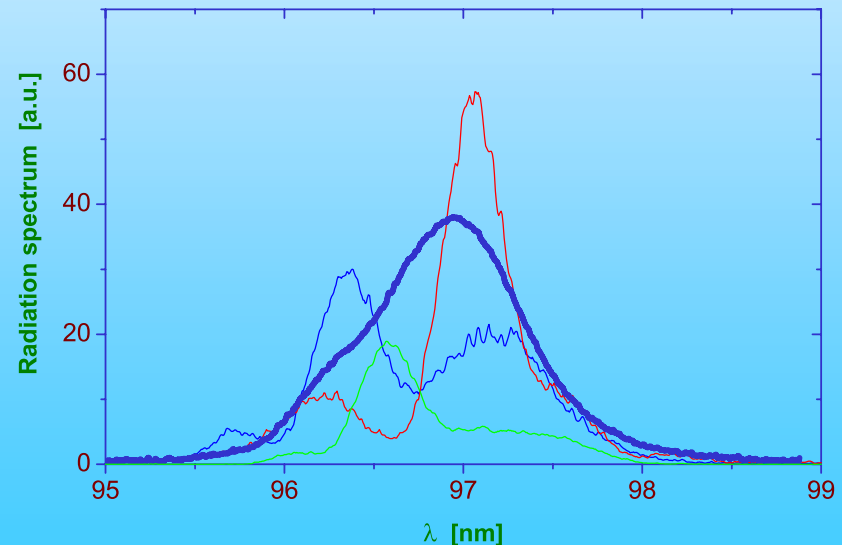


SASE Diagnostics

- Tolerances on Machine Settings are very tight!
- ⇒ Light Production has to be controlled from the Operators Console.
- Operator needs to keep optimum Performance:
 - SASE Signal + Statistics
 - Radiation Spectrum (Pulse Length)
 (few modes only ⇒ high peak power, Operation Experience of TTF I)



MCP has been calibrated for
different voltage settings
dynamic range: 10^7



Thin lines: Single Shot Spectrum
Bold: Average over many Shots

Conclusion

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I am sure time is over

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